

**Notice of References Cited**

Application/Control No.

09/611,809

Applicant(s)/Patent Under  
Reexamination  
CHIN ET AL.

Examiner

Carl Colin

Art Unit

2136

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,209,016	03-2001	Hobson et al.	708/491
*	B	US-6,064,740	05-2000	Curiger et al.	380/265
*	C	US-6,633,563	10-2003	Lin et al.	370/389
*	D	US-6,289,462	09-2001	McNabb et al.	726/21
*	E	US-6,351,760	02-2002	Shankar et al.	708/654
*	F	US-6,434,699	08-2002	Jones et al.	713/168
*	G	US-6,237,016	05-2001	Fischer et al.	708/622
*	H	US-3,665,411	05-1972	O'Connor, Daniel G.	712/222
*	I	US-4,507,728	03-1985	Sakamoto et al.	712/1
*	J	US-5,227,987	07-1993	Imazawa et al.	708/7
*	K	US-5,870,596	02-1999	Yoshida, Toyohiko	712/225
*	L	US-6,385,634	05-2002	Peleg et al.	708/490
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 601907 A2	06-1994	European Patent	GRESSEL et al.	G06F 07/72
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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